Notice of References Cited Application/Control No. 09/929,708 Applicant(s)/Patent Under Reexamination NISHIKI, HIROHIKO Examiner A. Sefer Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,892,558	04-1999	Ge et al.	349/43
	В	US-6,104,457	08-2000	Izumi et al.	349/73
	С	US-6,191,007 /	02-2001	Matsui et al.	438/459
	D	US-5,459,335	10-1995	Matsushita et al.	257/59
	E	US-6,285,433	09-2001	Kawasaki, Kiyohiro	349/149
	F	US-5,742,006	04-1998	Grupp et al.	174/52.2
	G	US-6275277	08-2001	Walker et al	349/113
	Н	US-5621550	04-1997	Oku	. 349/5
	ı	US-5808410	09-1998	Pinker et al	313/493
	J	US-5629787 /	05-1997	Tsubota et al	349/153
	К	US-6290793	09-2001	Lovas et al	156/99
	L	US-6612888	09-2003	Pei et al	445/24
	М	US-6057898	05-2000	Itoh et al	349/73

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 11-24047 /	01-1999	Japan	Fujimori et al	
	0	JP 1-138538 /	05-1989	Japan	Odai e al	
	Р	JP 57-35830 /	02-1982	Japan		
	Q	JP 2000-25000	09-2000	Japan		
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.